

Notice of References Cited

Application/Control No.

10/798,917

Applicant(s)/Patent Under
Reexamination
DOVE, KEVIN E.

Examiner

Hai Vo

Art Unit

1771

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0230859	12-2003	Hisano et al.	277/610
	B	US-			
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	F	US-			
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	I	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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